

filed 6/28/03

FORM PTO-1449 LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT (use several sheets if necessary)	SERIAL NO. To be Assigned	CASE NO. 9281/4579
	FILING DATE Herewith	GROUP ART UNIT
	APPLICANT(S): Naoya Hasegawa et al.	

REFERENCE DESIGNATION			U.S. PATENT DOCUMENTS			
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS/SUBCLASS	FILING DATE

FOREIGN PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	COUNTRY	CLASS/SUBCLASS	TRANSLATION YES	NO
<i>Handwritten</i>	A1	2001-273613	10/2001	JP	/	x	
1	A2	2001-291214	10/2001	JP		x	
2	A3	2001-155313	6/2001	JP		x	
4	A4	2001-256617	9/2001	JP		x	
	A						

EXAMINER INITIAL	OTHER ART (Including Author, Title, Date, Pertinent Pages, etc.)					

EXAMINER <i>Kim M. Roberts</i>	DATE CONSIDERED 2/1/05
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EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



FORM PTO-1449 LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT (use several sheets if necessary)	SERIAL NO. 10/607,238	CASE NO. 9281-4579
	FILING DATE June 25, 2003	GROUP ART UNIT 2862
	APPLICANT(S): Naoya Hasegawa et al.	

REFERENCE DESIGNATION

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS/ SUBCLASS	FILING DATE
<i>LM</i>	B1	2002/0135956	09/2002	Naoya Hasegawa et al.		
<i>LI</i>	B2	2002/0051330	05/2002	Petrus Antonius Van der Heijden et al.		
<i>I</i>	B3	2002/0054461	05/2002	Hideo Fujiwara et al.		

FOREIGN PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	COUNTRY	CLASS/ SUBCLASS	TRANSLATION YES	NO

EXAMINER INITIAL	OTHER ART (Including Author, Title, Date, Pertinent Pages, etc.)

EXAMINER <i>Wm. M. Kelly</i>	DATE CONSIDERED <i>2/1/05</i>
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(use several sheets if necessary)

10/607,238

9281-4579

June 25, 2003

2862

APPLICANT(S): Naoya Hasegawa et al.

U.S. PATENT DOCUMENTS

FOREIGN PATENT DOCUMENTS

EXAMINER INITIAL	OTHER ART (Including Author, Title, Date, Pertinent Pages, etc.)
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EXAMINER

DATE CONSIDERED

211/05

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.